

Notice of References Cited	Application/Control No. 10/735,409	Applicant(s)/Patent Under Reexamination YOON ET AL.	
	Examiner Tho D. Ta	Art Unit 2833	Page 1 of 1

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	B	US-3,990,761	11-1976	Jayne, Max Leroy	439/267
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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